

<b>Notice of References Cited</b>	Application/Control No. 09/739,582	Applicant(s)/Patent Under Reexamination TEIG ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6263475 - B1 /	07-2001	Toyonaga et al.	716/2
	B	US-5980093 - A /	11-1999	Jones et al.	716/5
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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